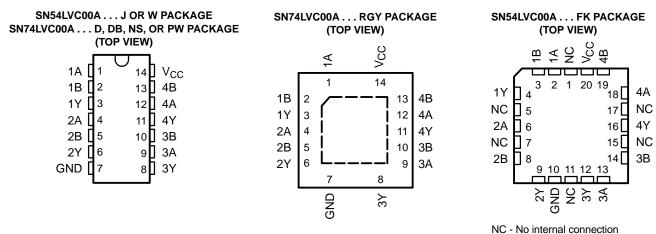


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## FEATURES

- Operate From 1.65 V to 3.6 V
- Specified From -40°C to 85°C, -40°C to 125°C, and -55°C to 125°C
- Inputs Accept Voltages to 5.5 V
- Max t<sub>pd</sub> of 4.3 ns at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  <0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
  >2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C

- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)



## **DESCRIPTION/ORDERING INFORMATION**

The SN54LVC00A quadruple 2-input positive-NAND gate is designed for 2.7-V to 3.6-V V<sub>CC</sub> operation, and the SN74LVC00A quadruple 2-input positive-NAND gate is designed for 1.65-V to 3.6-V V<sub>CC</sub> operation.

The 'LVC00A devices perform the Boolean function  $Y = \overline{A \cdot B}$  or  $Y = \overline{A} + \overline{B}$  in positive logic.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Copyright © 1993–2005, Texas Instruments Incorporated On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

# SN54LVC00A, SN74LVC00A QUADRUPLE 2-INPUT POSITIVE-NAND GATES

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T <sub>A</sub>	P/	CKAGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 85°C	QFN – RGY	Reel of 1000	SN74LVC00ARGYR	LC00A
		Tube of 50	SN74LVC00AD	
	SOIC – D	Reel of 2500	SN74LVC00ADR	LVC00A
		Reel of 250	SN74LVC00ADT	-
	SOP – NS	Reel of 2000	SN74LVC00ANSR	LVC00A
–40°C to 125°C	SSOP – DB	Reel of 2000	SN74LVC00ADBR	LC00A
		Tube of 90	SN74LVC00APW	
	TSSOP – PW	Reel of 2000	SN74LVC00APWR	LC00A
		Reel of 250	SN74LVC00APWT	-
	CDIP – J	Tube of 25	SNJ54LVC00AJ	SNJ54LVC00AJ
–55°C to 125°C	CFP – W	Tube of 150	SNJ54LVC00AW	SNJ54LVC00AW
	LCCC – FK	Tube of 55	SNJ54LVC00AFK	SNJ54LVC00AFK

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE (EACH GATE)							
INP	UTS	OUTPUT					
Α	В	Y					
Н	Н	L					
L	Х	Н					
Х	L	Н					

### LOGIC DIAGRAM, EACH GATE (POSITIVE LOGIC)



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# Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	6.5	V
VI	Input voltage range <sup>(2)</sup>		-0.5	6.5	V
Vo	Output voltage range <sup>(2)(3)</sup>		-0.5	$V_{CC} + 0.5$	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current			±50	mA
V <sub>CC</sub>	Continuous current through GND			±100	mA
		D package <sup>(4)</sup>		86	
		DB package <sup>(4)</sup>		96	
$\theta_{JA}$	Package thermal impedance	NS package <sup>(4)</sup>		76	°C/W
		PW package <sup>(4)</sup>		113	
		RGY package <sup>(5)</sup>		47	
T <sub>stg</sub>	Storage temperature range		-65	150	°C
P <sub>tot</sub>	Power dissipation <sup>(6)(7)</sup>	$T_A = -40^{\circ}C$ to $125^{\circ}C$		500	mW

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed. (2)

(3) The value of V<sub>CC</sub> is provided in the recommended operating conditions table. (4) The package thermal impedance is calculated in accordance with JESD 51-7.

The package thermal impedance is calculated in accordance with JESD 51-5.

(5) (6)

For the D package: above 70°C, the value of  $P_{tot}$  derates linearly with 8 mW/K. For the DB, NS, and PW packages: above 60°C, the value of  $P_{tot}$  derates linearly with 5.5 mW/K. (7)

# SN54LVC00A, SN74LVC00A QUADRUPLE 2-INPUT POSITIVE-NAND GATES

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# **Recommended Operating Conditions**<sup>(1)</sup>

			SN54LV	C00A	
			–55°C to	–55°C to 125°C	
			MIN	MAX	
V	Supply voltogo	Operating	2	3.6	V
V <sub>CC</sub>	Supply voltage	Data retention only	1.5		v
VIH	High-level input voltage	V <sub>CC</sub> = 2.7 V to 3.6 V	2		V
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 2.7 V to 3.6 V		0.8	V
VI	Input voltage	· · · ·	0	5.5	V
Vo	Output voltage		0	V <sub>CC</sub>	V
		V <sub>CC</sub> = 2.7 V		-12	
I <sub>OH</sub>	High-level output current	$V_{CC} = 3 V$		-24	mA
		V <sub>CC</sub> = 2.7 V		12	A
I <sub>OL</sub>	Low-level output current	$V_{CC} = 3 V$		24	mA

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

### **Recommended Operating Conditions**<sup>(1)</sup>

					SN74L	VC00A			
			T <sub>A</sub> = 25°C		-40°C	to 85°C	–40°C to 125°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
V	Supply voltogo	Operating	1.65	3.6	1.65	3.6	1.65	3.6	V
V <sub>CC</sub>	Supply voltage	Data retention only	1.5		1.5		1.5		V
		$V_{CC}$ = 1.65 V to 1.95 V	$0.65 \times V_{CC}$		$0.65 \times V_{\text{CC}}$		$0.65 \times V_{CC}$		
$V_{\text{IH}}$	High-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V	1.7		1.7		1.7		V
	input voltage	$V_{CC}$ = 2.7 V to 3.6 V	2		2		2		
		$V_{CC} = 1.65 \text{ V}$ to 1.95 V		$0.35\times V_{CC}$		$0.35 \times V_{CC}$		$0.35 \times V_{CC}$	
VIL	Low-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V		0.7		0.7		0.7	V
	input voltage	$V_{CC}$ = 2.7 V to 3.6 V		0.8		0.8		0.8	
VI	Input voltage		0	5.5	0	5.5	0	5.5	V
Vo	Output voltage		0	V <sub>CC</sub>	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
		V <sub>CC</sub> = 1.65 V		-4		-4		-4	
	High-level	$V_{CC} = 2.3 V$		-8		-8		-8	mA
I <sub>OH</sub>	output current	$V_{CC} = 2.7 V$		-12		-12		-12	ШA
		$V_{CC} = 3 V$		-24		-24		-24	
		V <sub>CC</sub> = 1.65 V		4		4		4	
	Low-level	V <sub>CC</sub> = 2.3 V		8		8		8	m۸
I <sub>OL</sub>	output current	V <sub>CC</sub> = 2.7 V		12		12		12	mA
1		$V_{CC} = 3 V$		24		24		24	

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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## **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

			SN54LVC00A	
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	–55°C to 125°C	UNIT
			MIN MAX	
	I <sub>OH</sub> = -100 μA	2.7 V to 3.6 V	V <sub>CC</sub> – 0.2	
N		2.7 V	2.2	V
V <sub>OH</sub>	$I_{OH} = -12 \text{ mA}$	3 V	2.4	
	$I_{OH} = -24 \text{ mA}$	3 V	2.2	
	I <sub>OL</sub> = 100 μA	2.7 V to 3.6 V	0.2	
V <sub>OL</sub>	I <sub>OL</sub> = 12 mA	2.7 V	0.4	V
	I <sub>OL</sub> = 24 mA	3 V	0.55	
I <sub>I</sub>	$V_{I} = 5.5 \text{ V or GND}$	3.6 V	±5	μA
I <sub>CC</sub>	$V_{I} = V_{CC}$ or GND, $I_{O} = 0$	3.6 V	10	μA
$\Delta I_{CC}$	One input at $V_{CC}$ – 0.6 V, Other inputs at $V_{CC}$ or GND	2.7 V to 3.6 V	500	μA

## **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

					S	N74LVC00A	١			
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	T <sub>A</sub>	= 25°C		–40°C to	85°C	–40°C to '	125°C	UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
	I <sub>OH</sub> = −100 μA	1.65 V to 3.6 V	$V_{CC} - 0.2$			$V_{CC} - 0.2$		V <sub>CC</sub> – 0.3		
	I <sub>OH</sub> = -4 mA	1.65 V	1.29			1.2		1.05		
M	I <sub>OH</sub> = -8 mA	2.3 V	1.9			1.7		1.55		V
V <sub>OH</sub>	10 m4	2.7 V	2.2			2.2		2.05		v
	$I_{OH} = -12 \text{ mA}$	3 V	2.4			2.4		2.25		
	I <sub>OH</sub> = -24 mA	3 V	2.3			2.2		2		
	I <sub>OL</sub> = 100 μA	1.65 V to 3.6 V			0.1		0.2		0.3	
	$I_{OL} = 4 \text{ mA}$	1.65 V			0.24		0.45		0.6	
V <sub>OL</sub>	I <sub>OL</sub> = 8 mA	2.3 V			0.3		0.7		0.85	V
	I <sub>OL</sub> = 12 mA	2.7 V			0.4		0.4		0.6	
	I <sub>OL</sub> = 24 mA	3 V			0.55		0.55		0.8	
I <sub>I</sub>	$V_{I} = 5.5 V \text{ or GND}$	3.6 V			±1		±5		±20	μA
I <sub>CC</sub>	$V_{I} = V_{CC}$ or GND, $I_{O} = 0$	3.6 V			1		10		40	μA
ΔI <sub>CC</sub>	One input at $V_{CC} - 0.6 V$ , Other inputs at $V_{CC}$ or GND	2.7 V to 3.6 V			500		500		5000	μΑ
Ci	$V_{I} = V_{CC}$ or GND	3.3 V		5						pF

# SN54LVC00A, SN74LVC00A **QUADRUPLE 2-INPUT POSITIVE-NAND GATES**

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### **Switching Characteristics**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

ŧ,

				SN54LV	C00A	
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>cc</sub>	–55°C to	125°C	UNIT
	(	(001101)		MIN	MAX	
+	A or P	V	2.7 V		5.1	20
Lpd	A or B	ř	$3.3~\text{V}\pm0.3~\text{V}$	1	4.3	ns

## **Switching Characteristics**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

							SN74L	/C00A			
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>cc</sub>	T,	<sub>4</sub> = 25°	С	–40°C t	o 85°C	–40°C to	125°C	UNIT
	( 01)	(001101)		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
			$1.8~V\pm0.15~V$	1	6	12	1	12.5	1	14	
+	A or B	V	$2.5~V\pm0.2~V$	1	4.6	5.9	1	6.4	1	7.9	20
lpd	AUB	T	2.7 V	1	4.3	4.9	1	5.1	1	6.5	ns
			$3.3~\text{V}\pm0.3~\text{V}$	1	3.5	4.1	1	4.3	1	5.5	
t <sub>sk(o)</sub>			$3.3~\textrm{V}\pm0.3~\textrm{V}$					1		1.5	ns

## **Operating Characteristics**

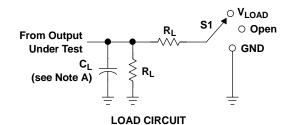
 $T_A = 25^{\circ}C$ 

	PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	TYP	UNIT
			1.8 V	18	
C <sub>pd</sub>	Power dissipation capacitance per gate	f = 10 MHz	2.5 V	18	pF
			3.3 V	19	

## SN54LVC00A, SN74LVC00A QUADRUPLE 2-INPUT POSITIVE-NAND GATES

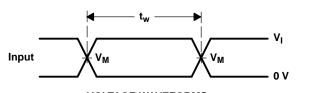
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### PARAMETER MEASUREMENT INFORMATION

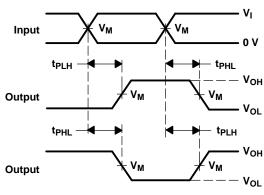


TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	VLOAD
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

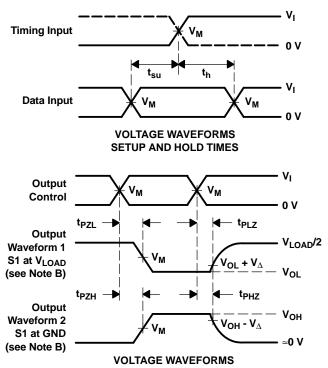
	INPUTS					_		
V <sub>CC</sub>	vı	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	RL	$\mathbf{V}_{\Delta}$	
1.8 V $\pm$ 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	$2 \times V_{CC}$	30 pF	<b>1 k</b> Ω	0.15 V	
$\textbf{2.5 V} \pm \textbf{0.2 V}$	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	$2 \times V_{CC}$	30 pF	<b>500</b> Ω	0.15 V	
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	



VOLTAGE WAVEFORMS PULSE DURATION



#### VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES INVERTING AND NONINVERTING OUTPUTS



#### ENABLE AND DISABLE TIMES LOW- AND HIGH-LEVEL ENABLING

- NOTES: A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ .
  - D. The outputs are measured one at a time, with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
  - H. All parameters and waveforms are not applicable to all devices.

### Figure 1. Load Circuit and Voltage Waveforms

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18-Sep-2008

## **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	n MSL Peak Temp <sup>(3)</sup>
5962-9753301Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
5962-9753301QCA	ACTIVE	CDIP	J	14	1	TBD	A42 SNPB	N / A for Pkg Type
5962-9753301QDA	ACTIVE	CFP	W	14	1	TBD	A42	N / A for Pkg Type
5962-9753301V2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
5962-9753301VCA	ACTIVE	CDIP	J	14	1	TBD	A42 SNPB	N / A for Pkg Type
5962-9753301VDA	ACTIVE	CFP	W	14	1	TBD	A42	N / A for Pkg Type
SN74LVC00AD	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADBLE	OBSOLETE	SSOP	DB	14		TBD	Call TI	Call TI
SN74LVC00ADBR	ACTIVE	SSOP	DB	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADBRE4	ACTIVE	SSOP	DB	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADBRG4	ACTIVE	SSOP	DB	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADE4	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADG4	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADRE4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADRG4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADT	ACTIVE	SOIC	D	14	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADTE4	ACTIVE	SOIC	D	14	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ADTG4	ACTIVE	SOIC	D	14	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ANSR	ACTIVE	SO	NS	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ANSRG4	ACTIVE	SO	NS	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00APW	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00APWE4	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00APWG4	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00APWLE	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI
SN74LVC00APWR	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00APWRE4	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00APWRG4	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74LVC00APWT	ACTIVE	TSSOP	PW	14	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00APWTE4	ACTIVE	TSSOP	PW	14	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00APWTG4	ACTIVE	TSSOP	PW	14	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC00ARGYR	ACTIVE	QFN	RGY	14	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN74LVC00ARGYRG4	ACTIVE	QFN	RGY	14	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SNJ54LVC00AFK	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type
SNJ54LVC00AJ	ACTIVE	CDIP	J	14	1	TBD	A42 SNPB	N / A for Pkg Type
SNJ54LVC00AW	ACTIVE	CFP	W	14	1	TBD	A42	N / A for Pkg Type

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### OTHER QUALIFIED VERSIONS OF SN54LVC00A, SN54LVC00A-SP, SN74LVC00A :

Automotive: SN74LVC00A-Q1

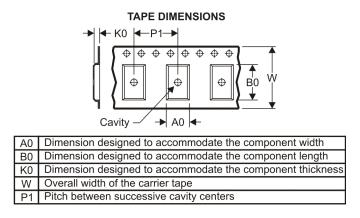
Enhanced Product: SN74LVC00A-EP

NOTE: Qualified Version Definitions:

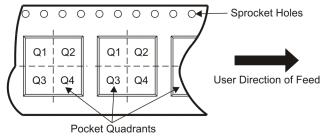
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

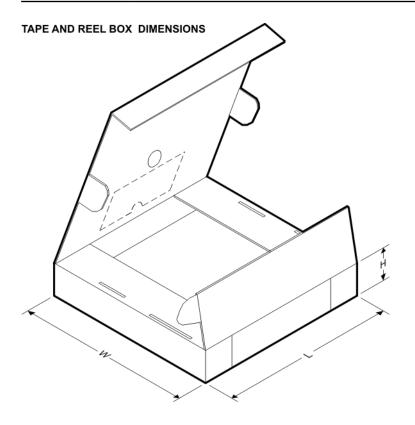


*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC00ADBR	SSOP	DB	14	2000	330.0	16.4	8.2	6.6	2.5	12.0	16.0	Q1
SN74LVC00ADR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74LVC00ADR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74LVC00ANSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74LVC00APWR	TSSOP	PW	14	2000	330.0	12.4	7.0	5.6	1.6	8.0	12.0	Q1
SN74LVC00ARGYR	QFN	RGY	14	1000	180.0	12.4	3.85	3.85	1.35	8.0	12.0	Q1



# PACKAGE MATERIALS INFORMATION

19-Mar-2008



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC00ADBR	SSOP	DB	14	2000	346.0	346.0	33.0
SN74LVC00ADR	SOIC	D	14	2500	346.0	346.0	33.0
SN74LVC00ADR	SOIC	D	14	2500	333.2	345.9	28.6
SN74LVC00ANSR	SO	NS	14	2000	346.0	346.0	33.0
SN74LVC00APWR	TSSOP	PW	14	2000	346.0	346.0	29.0
SN74LVC00ARGYR	QFN	RGY	14	1000	190.5	212.7	31.8

# **MECHANICAL DATA**

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

## DB (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



MLCC006B - OCTOBER 1996

### FK (S-CQCC-N\*\*)

### LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. The terminals are gold plated.
- E. Falls within JEDEC MS-004



# **MECHANICAL DATA**

MTSS001C - JANUARY 1995 - REVISED FEBRUARY 1999

# PW (R-PDSO-G\*\*)

### PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



## MECHANICAL DATA

### PLASTIC SMALL-OUTLINE PACKAGE

### 0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 $\bigcirc$ Gage Plane ₽ 0,25 7 1 1,05 0,55 0-10 Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS \*\* 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G\*\*)

**14-PINS SHOWN** 

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



J (R-GDIP-T\*\*) 14 LEADS SHOWN

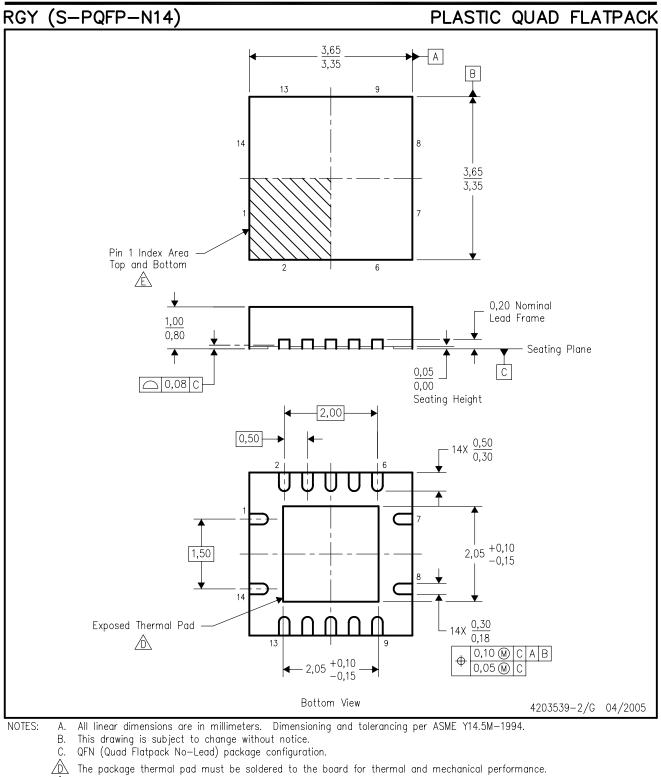
CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# **MECHANICAL DATA**



È Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.

F. Package complies to JEDEC MO-241 variation BA.



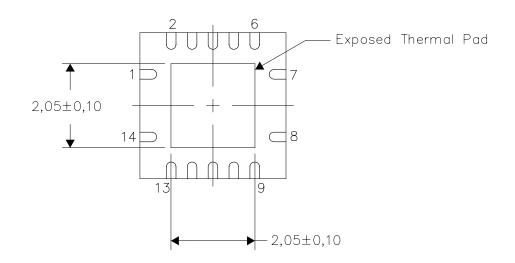


### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, Quad Flatpack No-Lead Logic Packages, Texas Instruments Literature No. SCBA017. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

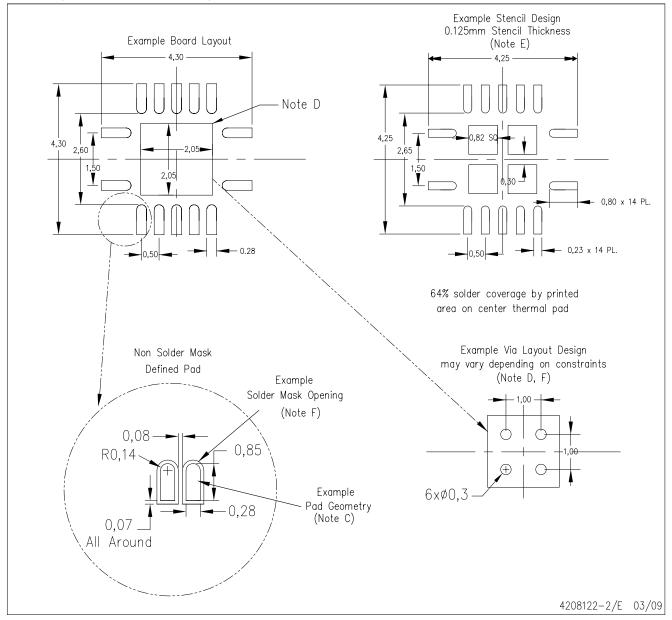




NOTE: All linear dimensions are in millimeters

Exposed Thermal Pad Dimensions

RGY (S-PVQFN-N14)



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.

D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.

E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.

F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



W (R-GDFP-F14)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. This package can be hermetically sealed with a ceramic lid using glass frit.
  - D. Index point is provided on cap for terminal identification only.
  - E. Falls within MIL STD 1835 GDFP1-F14 and JEDEC MO-092AB



D (R-PDSO-G14)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.

Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.

E. Reference JEDEC MS-012 variation AB.



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